

<b>Notice of References Cited</b>		Application/Control No. <b>09/439,915</b>	Applicant(s)/Patent Under Reexam <b>Seitz et al.</b>	
		Examiner <b>Jacqueline Wilson</b>	Art Unit <b>2612</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	6,011,251	1/2000	Dierickx et al.	348	297
B	6,493,025	12/2002	Kiryama et al.	348	231.99
C	6,115,065	9/2000	Yadid-Pecht et al.	348	308
D	4,647,975	3/1987	Alston et al.	348	222.1
E	5,144,442	9/1992	Ginosar et al.	348	222.1
F	6,175,383	1/2001	Yadid-Pecht et al.	348	297
G	6,429,898	8/2002	Shoda et al.	348	316
H	5,572,256	11/1996	Egawa et al.	348	296
I	6,204,881	3/2001	Ikeda et al.	348	362
J	6,441,851	8/2002	Yonemoto	348	297
K					
L					
M					

**FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N						
O						
P						
Q						
R						
S						
T						

**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
V	
W	
X	

<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.